

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application No.: 10/789,764

Filing Date: February 27, 2004

Applicant: Boisseau, et al.

Group Art Unit: 1709

Examiner: Christine T. Mui

Title: TEST METHOD FOR DETERMINING ETCH
PERFORMANCE OF A COATED SUBSTRATE

Attorney Docket: IN-5597 (HDP 0906S-000446/US)

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Commissioner for Patents
P.O. Box 1450
Alexandria, Virginia 22313-1450

RESPONSE AFTER FINAL

Sir:

In response to the Office Action mailed November 28, 2007, please consider the remarks set forth below.

Remarks begin on page 2 of this paper.